Cloud Security in the Age of IoT

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Deadline for manuscript submissions:
closed (1 September 2022)

Message from the Guest Editors

This Special Issue will be a forum to share both ideas and approaches to improve cloud security as well as concrete experiences specifically addressing security in IoT. In this context, we are envisaging works covering one or more of the following topics:

- IoT secure applications taking advantage of cloud computing;
- Emerging problems and recent trends in the field of IoT, fog, and edge computing;
- Distributed architectures in support of IoT security;
- Confidentiality, integrity and privacy for public, private, and hybrid clouds;
- Trust in IoT applications;
- Models and technologies for security management, configuration, and accounting;
- Security issues including secure communications and strategies to detect and mitigate attacks;
- Model-based analysis and security assessment;
- Simulation

https://www.mdpi.com/journal/electronics/special_issues/Cloud_Security_IoT

Welcome to contribute.

Special Issue

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Message from the Editor-in-Chief

Electronics is a multidisciplinary journal designed to appeal to a diverse audience of research scientists, practitioners, and developers in academia and industry. The journal is devoted to fast publication of latest technological breakthroughs, cutting-edge developments, and timely reviews of current and emerging technologies related to the broad field of electronics. Experimental and theoretical results are published as regular peer-reviewed articles or as articles within Special Issues guest-edited by leading experts in selected topics of interest.

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